

June 2009

FDMC8200

Dual N-Channel PowerTrench[®] MOSFET 30 V, 9.5 m Ω and 20 m Ω

Features

Q1: N-Channel

Max $r_{DS(on)}$ = 20 m Ω at V_{GS} = 10 V, I_D = 6 A

Max $r_{DS(on)}$ = 32 m Ω at V_{GS} = 4.5 V, I_D = 5 A

Q2: N-Channel

Max $r_{DS(on)}$ = 9.5 m Ω at V_{GS} = 10 V, I_D = 9 A

Max $r_{DS(on)}$ = 13.5 m Ω at V_{GS} = 4.5 V, I_D = 7 A

RoHS Compliant



General Description

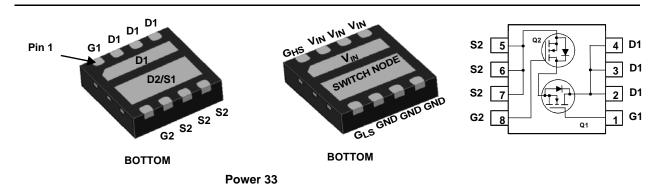
This device includes two specialized N-Channel MOSFETs in a dual Power33 (3mm x 3mm MLP) package. The switch node has been internally connected to enable easy placement and routing of synchronous buck converters. The control MOSFET (Q1) and synchronous MOSFET (Q2) have been designed to provide optimal power efficiency.

Applications

Mobile Computing

Mobile Internet Devices

General Purpose Point of Load



MOSFET Maximum Ratings T_C = 25 °C unless otherwise noted

Symbol	Parameter		Q1	Q2	Units	
V _{DS}	Drain to Source Voltage		30	30	V	
V _{GS}	Gate to Source Voltage	(Note 3)	±20	±20	V	
ID	Drain Current - Continuous (Package limited)	T _C = 25 °C	18	18		
	- Continuous (Silicon limited)	T _C = 25 °C	23	45	٨	
	- Continuous	T _A = 25 °C	8 ^{1a}	12 ^{1b}	— A	
	- Pulsed		40	40		
P _D	Power Dissipation	T _A = 25 °C	1.9 ^{1a}	2.2 ^{1b}	w	
	Power Dissipation	T _A = 25 °C	0.7 ^{1c}	0.9 ^{1d}	vv	
T _J , T _{STG}	Operating and Storage Junction Temperature Range		-55 to	+150	°C	

Thermal Characteristics

R_{\thetaJA}	Thermal Resistance, Junction to Ambient	65 ^{1a}	55 ^{1b}	
R_{\thetaJA}	Thermal Resistance, Junction to Ambient	180 ^{1c}	145 ^{1d}	°C/W
$R_{ extsf{ heta}JC}$	Thermal Resistance, Junction to Case	7.5	4	

Package Marking and Ordering Information

Device Marking	Device	Package	Reel Size	Tape Width	Quantity
FDMC8200	FDMC8200	Power 33	13 "	12 mm	3000 units

FDMC8200
Dual 1
N-Channel
PowerTrench

Symbol	Parameter	Test Conditions	Туре	Min	Тур	Max	Units
Off Chara	cteristics						
BV _{DSS}	Drain to Source Breakdown Voltage	$ I_D = 250 \; \mu \text{A}, \; \text{V}_{\text{GS}} = 0 \; \text{V} \\ I_D = 250 \; \mu \text{A}, \; \text{V}_{\text{GS}} = 0 \; \text{V} $	Q1 Q2	30 30			V
$\Delta BV_{DSS} \Delta T_J$	Breakdown Voltage Temperature Coefficient	$I_D = 250 \ \mu$ A, referenced to 25 °C $I_D = 250 \ \mu$ A, referenced to 25 °C	Q1 Q2		14 14		mV/°C
I _{DSS}	Zero Gate Voltage Drain Current	$V_{DS} = 24 V, V_{GS} = 0 V$ $V_{DS} = 24 V, V_{GS} = 0 V$	Q1 Q2			1 1	μA
I _{GSS}	Gate to Source Leakage Current	$V_{DS} = 20 \text{ V}, V_{GS} = 0 \text{ V}$	Q1 Q2			100 100	nA nA
On Chara	cteristics						
V _{GS(th)}	Gate to Source Threshold Voltage	$\begin{array}{l} V_{GS} = V_{DS}, \ I_D = 250 \ \mu\text{A} \\ V_{GS} = V_{DS}, \ I_D = 250 \ \mu\text{A} \end{array}$	Q1 Q2	1.0 1.0	2.3 2.3	3.0 3.0	V
$\frac{\Delta V_{GS(th)}}{\Delta T_J}$	Gate to Source Threshold Voltage Temperature Coefficient	I_D = 250 μ A, referenced to 25 °C I_D = 250 μ A, referenced to 25 °C	Q1 Q2		-5 -6		mV/°C
r _{DS(on)}	Static Drain to Source On Resistance		Q1		16 24 22	20 32 28	- mΩ
			Q2		7.3 9.5 10	9.5 13.5 13	11122
9 _{FS}	Forward Transconductance	$V_{DD} = 5 \text{ V}, \ I_D = 6 \text{ A}$ $V_{DD} = 5 \text{ V}, \ I_D = 9 \text{ A}$	Q1 Q2		29 56		S
Dynamic	Characteristics						
C _{iss}	Input Capacitance		Q1 Q2		495 1180	660 1570	pF
C _{oss}	Output Capacitance	V _{DS} = 15 V, V _{GS} = 0 V, f = 1 MHZ	Q1 Q2		145 330	195 440	pF
C _{rss}	Reverse Transfer Capacitance		Q1 Q2		20 30	30 45	pF
R _g	Gate Resistance		Q1 Q2		1.4 1.4		Ω
Switching	g Characteristics						
t _{d(on)}	Turn-On Delay Time	Q1	Q1 Q2		11 13	20 23	ns
t _r	Rise Time	$V_{DD} = 15 \text{ V}, \text{ I}_{D} = 1 \text{ A},$ $V_{GS} = 10 \text{ V}, \text{ R}_{GEN} = 6 \Omega$	Q1 Q2		3.1 4	10 10	ns
t _{d(off)}	Turn-Off Delay Time	Q2 V _{DD} = 15 V, I _D = 1 A,	Q1 Q2		35 38	56 60	ns
t _f	Fall Time	$V_{GS} = 10 \text{ V}, \text{ R}_{GEN} = 6 \Omega$	Q1 Q2		1.3 6	10 12	ns
			-				

Q_{g(TOT)}

Q_{g(TOT)}

 Q_gs

 Q_{gd}

Total Gate Charge

Total Gate Charge

Gate to Source Charge

Gate to Drain "Miller" Charge

2

 $V_{GS} = 0 V$ to 10 V

 $V_{GS} = 0 V$ to 4.5 V

Q1:

Q2:

V_{DD} = 15 V,

V_{DD} = 15 V, I_D = 9 A,

I_D = 6 A,

Q1

Q2

Q1

Q2

Q1

Q2

Q1

Q2

7.3

16

3.1

7

1.8

4.1

1

1.5

10

22

4.3

10

nC

nC

nC

nC

FDMC8200
) Dual N
N-Channel F
PowerTrenc
h [®] MOSFET

Symbol	Parameter	Test Conditions		Туре	Min	Тур	Max	Units
Drain-Sou	urce Diode Characteristics							
V _{SD}	Source to Drain Diode Forward Volt- age	00 / 0	Note 2) Note 2)	Q1 Q2		0.8 0.8	1.2 1.2	V
t _{rr}	Reverse Recovery Time	Q1 I _F = 6 A, di/dt = 100 A/μs		Q1 Q2		13 21	24 34	ns
Q _{rr}	Reverse Recovery Charge	Q2 I _F = 9 A, di/dt = 100 A/μs		Q1 Q2		2.3 5.6	10 12	nC

Notes:

1. R_{0JA} is determined with the device mounted on a 1in² pad 2 oz copper pad on a 1.5 x 1.5 in. board of FR-4 material. R_{0JC} is guaranteed by design while R_{0CA} is determined by the user's board design.

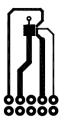


00000



c. 180 °C/W when mounted on a minimum pad of 2 oz copper

a.65 °C/W when mounted on a 1 in $^2\,$ pad of 2 oz copper



ŝ

80000

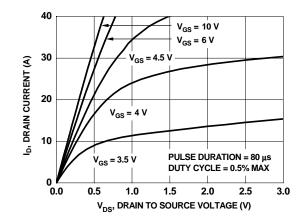
d. 145 °C/W when mounted on a minimum pad of 2 oz copper

b.55 °C/W when mounted on a 1 in² pad of 2 oz copper

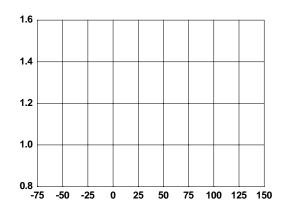
2. Pulse Test: Pulse Width < 300 µs, Duty cycle < 2.0%.

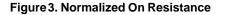
3. As an N-ch device, the negative Vgs rating is for low duty cycle pulse ocurrence only. No continuous rating is implied.

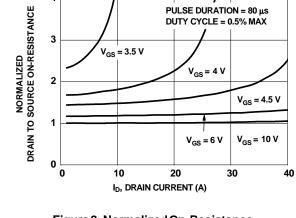
Typical Characteristics (Q1 N-Channel) T_J = 25 °C unless otherwise noted







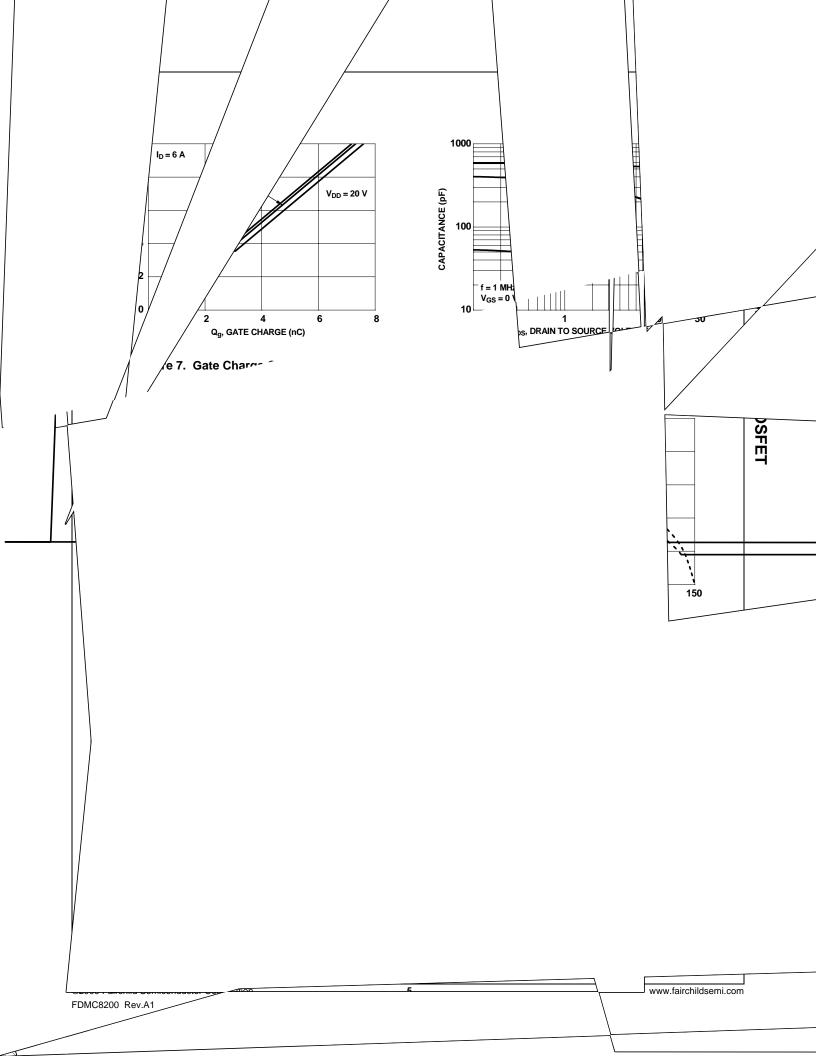


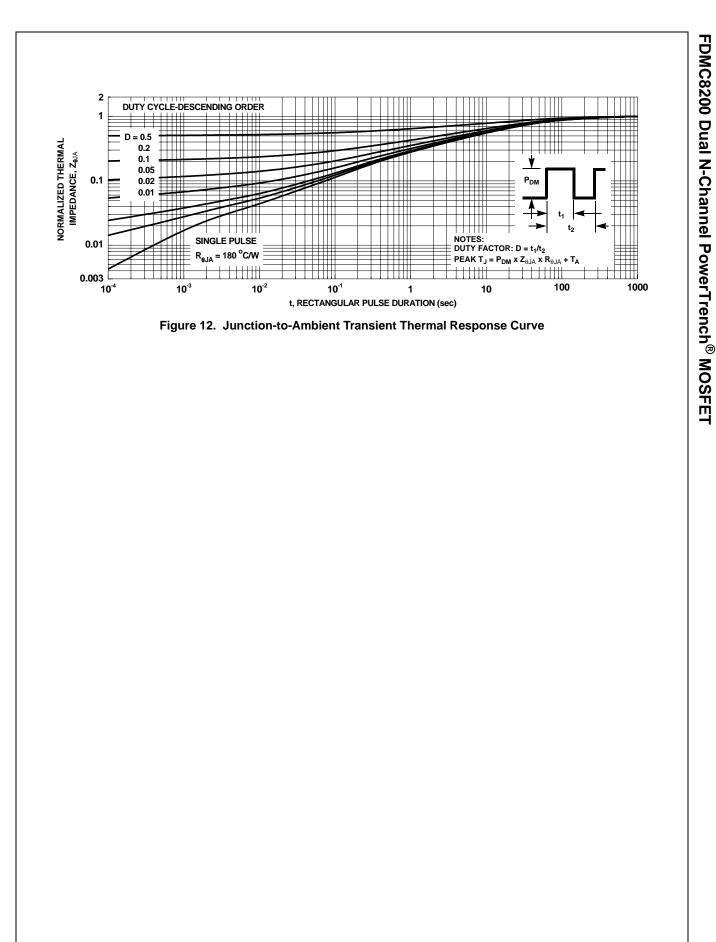


4

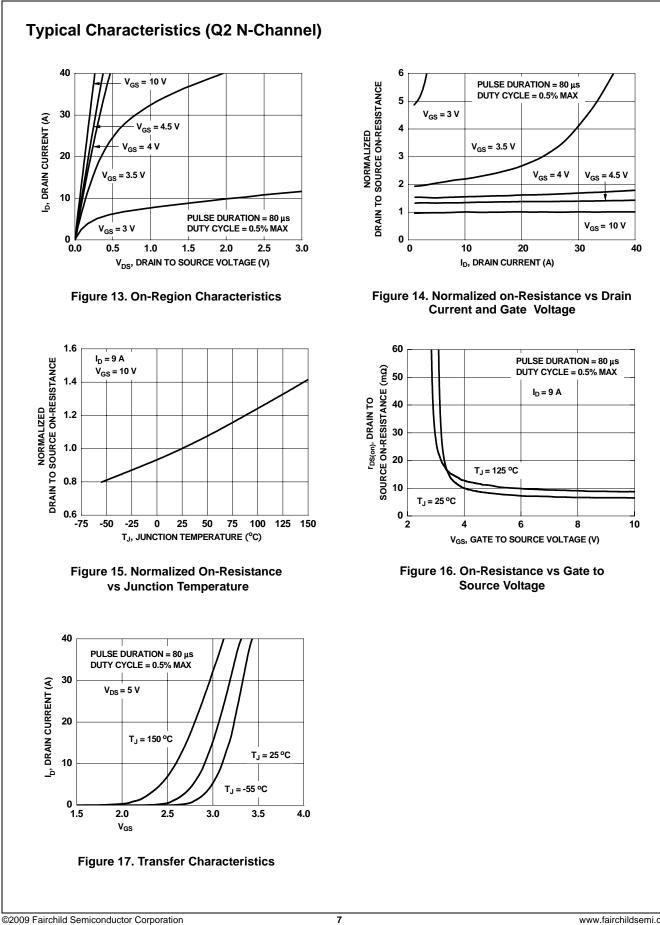
Figure 2. Normalized On-Resistance vs Drain Current and Gate Voltage

4

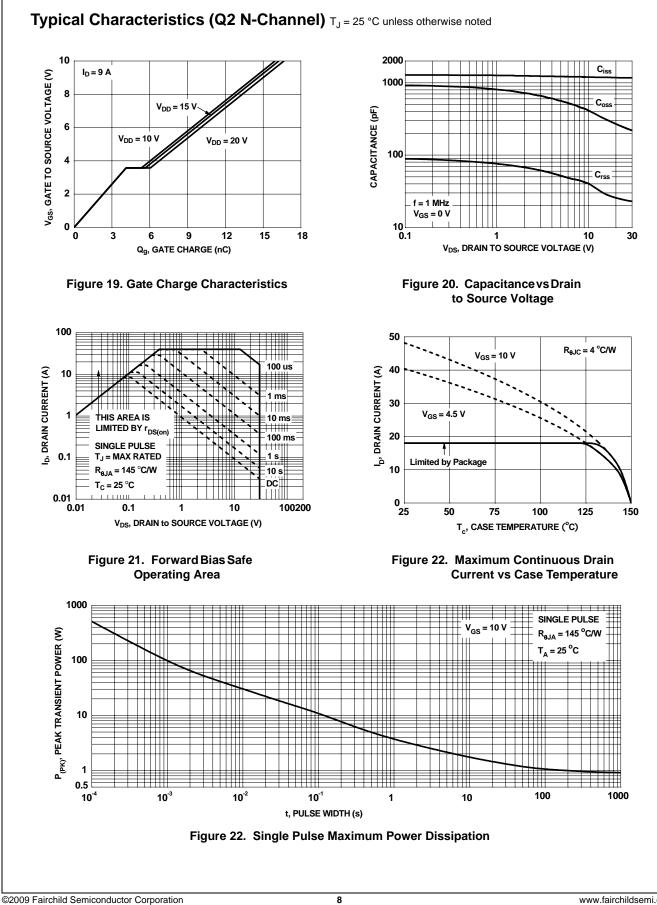




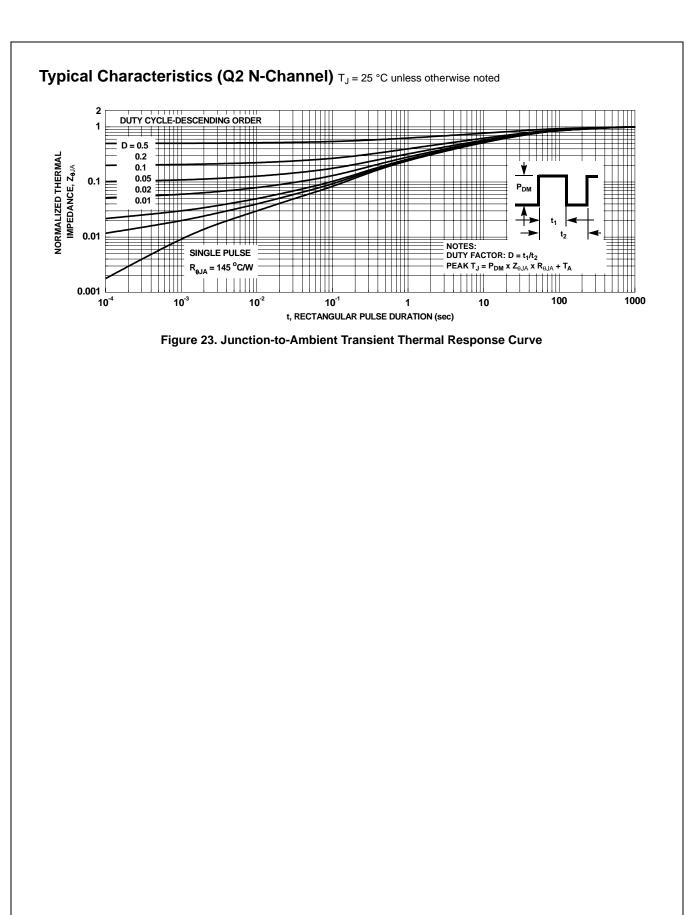
FDMC8200 Dual N-Channel PowerTrench[®] MOSFET

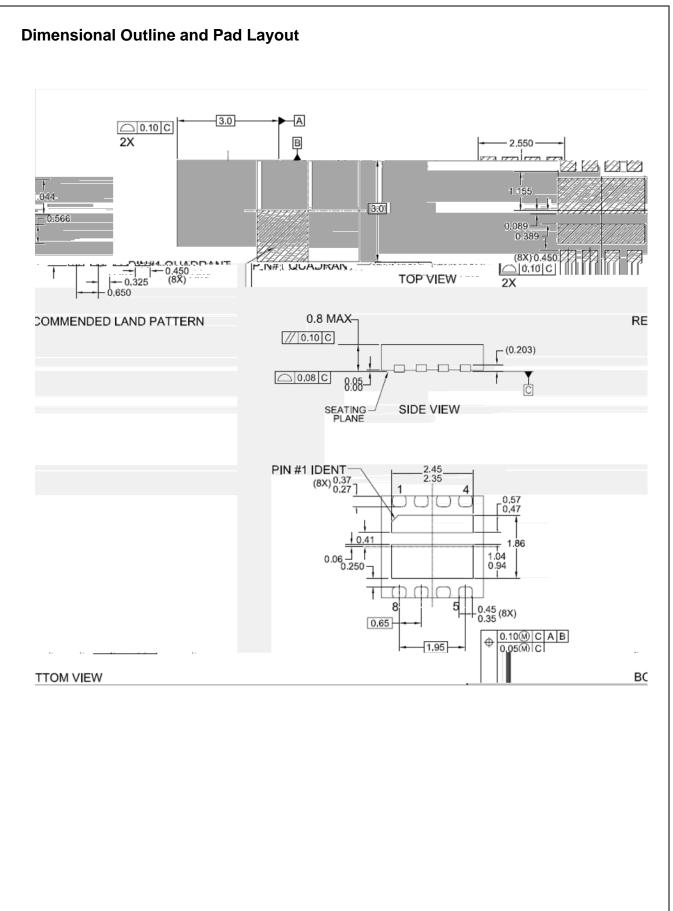












10



SEMICONDUCTOR

TRADEMARKS

The following includes registered and unregistered trademarks and service marks, owned by Fairchild Semiconductor and/or its global subsidiaries, and is not intended to be an exhaustive list of all such trademarks.

Auto-SPM TM Build it Now TM CorePLUS TM CorePOWER TM CroePOWER TM CROSSVOLT TM CTL TM CTL TM Current Transfer Logic TM EcoSPARK [®] EfficentMax TM EZSWITCH TM * EXECTIONAL TM* TM* Fairchild [®] Fairchild [®] Fairchild [®] Fairchild [®] Fairchild [®] Fairchild Semiconductor [®] FACT Quiet Series TM FACT [®] FAST [®] FastvCore TM FETBench TM FlashWriter [®] *	F-PFSTM FRFET® Global Power Resource SM Green FPSTM Green FPSTM e-SeriesTM GmaxTM GTOTM IntelliMAXTM ISOPLANARTM MigaBuckTM MICROCOUPLERTM MicroFETTM MicroPakTM MillerDriveTM MotionAaxTM Motion-SPMTM OPTOLOGIC® OPTOPLANAR® W DP SPMTM Power-SPMTM	QS TM Quiet Series TM RapidConfigure TM \bigcirc _{TM} Saving our world, 1mW /W /kW at a time TM SmartMax TM SMART START TM SPM [®] STEALTH TM SuperSOT TM -3 SuperSOT TM -6 SuperSOT TM -6 SuperSOT TM -8 SuprET TM SyncFET TM SyncFET TM	The Power Franchise [®] pranchise TinyBoost TM TinyBuck TM TinyDuck TM TinyPower TM TinyPWM TM TinyPWM TM TinyWire TM TriFault Detect TM TRUECURRENT ^{TM*} μserDes TM UHC [®] UHC [®] UHra FRFET TM VCX TM VisualMax TM XS TM
	PDP SPM™ Power-SPM™	Sýnc-Lock™ SYSTEM ®* GENERAL	
*Trademarks of System General Corp	oration, used under license by Fairchild	Semiconductor.	

DISCLAIMER

FAIRCHILD SEMICONDUCTOR RESERVES THE RIGHT TO MAKE CHANGES WITHOUT FURTHER NOTICE TO ANY PRODUCTS HEREIN TO IMPROVE RELIABILITY, FUNCTION, OR DESIGN. FAIRCHILD DOES NOT ASSUME ANY LIABILITY ARISING OUT OF THE APPLICATION OR USE OF ANY PRODUCT OR CIRCUIT DESCRIBED HEREIN; NEITHER DOES IT CONVEY ANY LICENSE UNDER ITS PATENT RIGHTS, NOR THE RIGHTS OF OTHERS. THESE SPECIFICATIONS DO NOT EXPAND THE TERMS OF FAIRCHILD'S WORLDWIDE TERMS AND CONDITIONS, SPECIFICALLY THE WARRANTY THEREIN, WHICH COVERS THESE PRODUCTS.

LIFE SUPPORT POLICY FAIRCHILD'S PRODUCTS ARE NOT AUTHORIZED FOR USE AS CRITICAL COMPONENTS IN LIFE SUPPORT DEVICES OR SYSTEMS WITHOUT THE EXPRESS WRITTEN APPROVAL OF FAIRCHILD SEMICONDUCTOR CORPORATION.

As used herein:

- 1 Life support devices or systems are devices or systems which, (a) are intended for surgical implant into the body or (b) support or sustain life, and (c) whose failure to perform when properly used in accordance with instructions for use provided in the labeling, can be reasonably expected to result in a significant injury of the user.
- 2 A critical component in any component of a life support, device, or system whose failure to perform can be reasonably expected to cause the failure of the life support device or system, or to affect its safety or effectiveness

ANTI-COUNTERFEITING POLICY

Fairchild Semiconductor Corporation's Anti-Counterfeiting Policy. Fairchild's Anti-Counterfeiting Policy is also stated on our external website, www.Fairchildsemi.com, under Sales Support.

Counterfeiting of semiconductor parts is a growing problem in the industry. All manufactures of semiconductor products are experiencing counterfeiting of their parts. Customers who inadvertently purchase counterfeit parts experience many problems such as loss of brand reputation, substandard performance, failed application, and increased cost of production and manufacturing delays. Fairchild is taking strong measures to protect ourselves and our customers from the proliferation of counterfeit parts. Fairchild strongly encourages customers to purchase Fairchild parts either directly from Fairchild or from Authorized Fairchild Distributors who are listed by country on our web page cited above. Products customers buy either from Fairchild directly or from Authorized Fairchild Distributors are genuine parts, have full traceability, meet Fairchild's quality standards for handing and storage and provide access to Fairchild's full range of up-to-date technical and product information. Fairchild and our Authorized Distributors will stand behind all warranties and will appropriately address and warranty issues that may arise. Fairchild will not provide any warranty coverage or other assistance for parts bought from Unauthorized Sources. Fairchild is committed to combat this global problem and encourage our customers to do their part in stopping this practice by buying direct or from authorized distributors.

PRODUCT STATUS DEFINITIONS Definition of Terms

Datasheet Identification	Product Status	Definition
Advance Information	Formative / In Design	Datasheet contains the design specifications for product development. Specifications may change in any manner without notice.
Preliminary	First Production	Datasheet contains preliminary data; supplementary data will be published at a later date. Fairchild Semiconductor reserves the right to make changes at any time without notice to improve design.
No Identification Needed	Full Production	Datasheet contains final specifications. Fairchild Semiconductor reserves the right to make changes at any time without notice to improve the design.
Obsolete	Not In Production	Datasheet contains specifications on a product that is discontinued by Fairchild Semiconductor. The datasheet is for reference information only.